

PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	SAU	EXAMINER
10008786	11/13/2001	374		2859	V...

APPLICANTS

Pavlidis Ioannis;

W *Levin, James A.*

**CONTINUING DATA VERIFIED:

THIS APPLN CLAIMS BENEFIT OF 60/285,004 04/19/2001

ABANDONED

** FOREIGN APPLICATIONS VERIFIED:

DO NOT PUBLISH ☐

RESCIND ☐

Foreign priority claimed

☐ yes ☒ no

35 USC 119 conditions met

☐ yes ☒ no

Verified and Acknowledged Examiner's initials

ATTORNEY DOCKET NO

H0002443-02

TITLE: System and method using thermal image analysis and slope threshold classification for polygraph testing

U.S. DEPT. OF COMMERCE/PAT. & TM-PTO-4361 (Rev. 12-97)

NOTICE (IF ALLOWANCE MAILED)

7/29/03

ISSUE FEE

Amount Due
\$1600

Date Paid

11/3/03



TERMINAL

DISCLAIMER

Gail Verbitsky

Assistant Examiner 2859

07/17/03

Gail Verbitsky

Primary Examiner

PREPARED FOR ISSUE

CLAIMS ALLOWED

Total Claims

31

Print Claim for

O.G. 1

DRAWING

Sheets Drwg.

9

Figs. Drwg.

15

Print Fig.

3, 11A

P. Wells
Application Examiner

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